



Nano: structural, microstructural and experimental CIF tags for an ontology

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Crystallography probes down to nanoscale

From crystalline to amorphous states

Single crystals, Textured, Powders

Thin architectures and bulks

Structure

Microstructure

Phase content

Residual Stresses

Roughness

Thickness

Magnetism

Texture

Porosity

Crystallographic Techniques

Diffraction (scattering + interferences): X, γ , n, e^-

Reflectivity (specular, off-specular): x-rays and neutrons

Small-Angles Scattering: x-rays (SAXS), neutrons (SANS)

Tomography (absorption or phase contrasts): x-rays, neutrons, electrons

Spectroscopy: X (XRF, XANES, EXAFS, DAFS)
 e^- (EDS)
 μ^+ (μ SR)

Crystallography Information File (CIF)

CIF dictionaries provide a formal taxonomy of crystallographic terms and ideas. Dictionary entries are constructed in a structured machine-readable manner that facilitates validation and structuring of data: <http://www.iucr.org/resources/cif/dictionaries>

Dictionaries: Core, Restraints, Powder, Modulated-Composite, Electron density, Twinning, Macromolecular, Images, Symmetry

Local dictionaries: reflectivity (to come), MPOD (Properties), MAUD

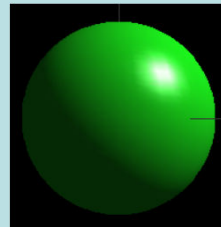
Structure (unit-cell metric, atomic positions, thermal vibrations)

```
_cell_length_a 5.959(1)
_cell_length_b 14.956(1)
_cell_length_c 19.737(3)
_cell_angle_alpha 90
_cell_angle_beta 90
_cell_angle_gamma 90
_cell_volume 1759.0(3)
_cell_measurement_temperature 293
_cell_measurement_reflns_used 25
_cell_measurement_theta_min 25
_cell_measurement_theta_max 31
```

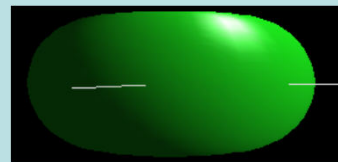
```
loop_
_atom_site_aniso_label
_atom_site_aniso_B_11
_atom_site_aniso_B_22
_atom_site_aniso_B_33
_atom_site_aniso_B_12
_atom_site_aniso_B_13
_atom_site_aniso_B_23
_atom_site_aniso_type_symbol
O1 .071(1) .076(1) .0342(9) .008(1) .0051(9) -.0030(9) O
O
C2 .060(2) .072(2) .047(1) .002(2) .013(1) -.009(1) C
C3 .038(1) .060(2) .044(1) .007(1) .001(1) -.005(1) C
N4 .037(1) .048(1) .0325(9) .0025(9) .0011(9) -.0011(9) N
N
C5 .043(1) .060(1) .032(1) .001(1) -.001(1) .001(1) C
# - - - - data truncated for brevity - - - -
O21 .094(2) .109(2) .068(1) .023(2) .038(1) -.010(1) O
C51 .048(2) .059(2) .049(1) .002(1) -.000(1) .007(1) C
C511 .048(2) .071(2) .097(3) -.008(2) -.003(2) .010(2) C
C512 .078(2) .083(2) .075(2) .009(2) -.005(2) .033(2) C
C513 .074(2) .055(2) .075(2) .004(2) .001(2) -.010(2) C
```

Microstructure, 3D to 0D, iso-anisotropic: size, distributions, twin faults, antiphase boundaries, stacking faults, turbostratism, interstitials, microdistortions ...)

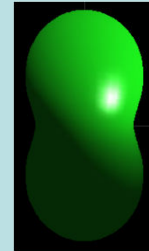
$\bar{1}$



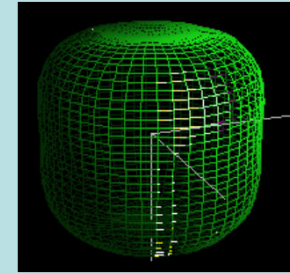
R_0



$R_0, R_1 < 0$



$R_0, R_1 > 0$



$R_0, R_6 < 0$

$$\langle R_h \rangle = R_0 + R_1 P_2^0(x) + R_2 P_2^1(x) \cos \varphi + R_3 P_2^1(x) \sin \varphi + R_4 P_2^2(x) \cos 2\varphi + R_5 P_2^2(x) \sin 2\varphi +$$

$$\langle \epsilon_h^2 \rangle E_h^4 = E_1 h^4 + E_2 k^4 + E_3 h^4 + 2E_4 h^2 k^2 + 2E_5 k^2 h^2 + 2E_6 h^2 k^2 + 4E_7 h^3 k + 4E_8 h^3 k + 4E_9 k^3 h + 4E_{10} k^3 h + 4E_{11} h^3 k + 4E_{12} k^3 h + 4E_{13} h^2 k + 4E_{14} k^2 h + 4E_{15} h^2 k h$$

```
#subordinateObject_Popa rules

_riet_sizestrain_sym_model 'Popa rules'

_rita_harmonic_expansion_degree 4

loop_
_riet_par_anisocryst_size
3129.8965(67.47402)
-339.8306(43.31268)
455.05365(37.83163)
1003.05383(27.05627)

loop_
_riet_par_aniso_microstrain
2.627043E-4(2.0511094E-5)
-3.466392E-5(3.9479637E-5)
3.5241275E-5(5.5889054E-6)
2.1924837E-4(4.90759E-6)

#end_subordinateObject_Popa rules
```

Tensor properties: c_{ij} , d_{ij} , π_{ijkl} ...

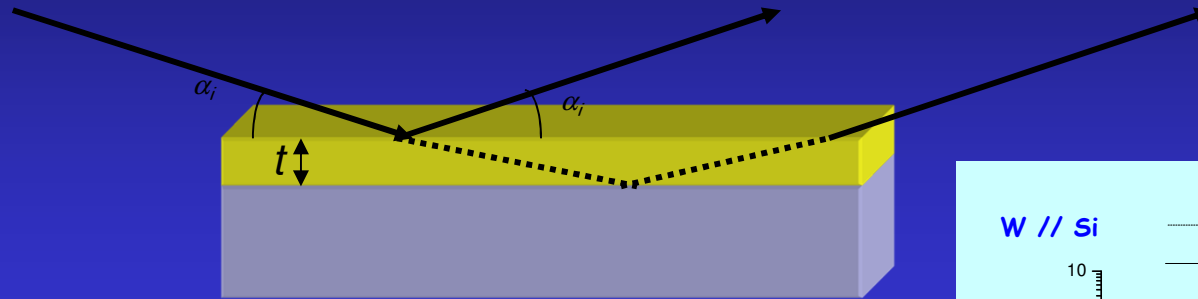
| | | | | | |
|----------|----------|----------|----------|----------|----------|
| c_{11} | c_{12} | c_{13} | c_{14} | c_{15} | c_{16} |
| | c_{22} | c_{23} | c_{24} | c_{25} | c_{26} |
| | | c_{33} | c_{34} | c_{35} | c_{36} |
| | | | c_{44} | c_{45} | c_{46} |
| | | | | c_{55} | c_{56} |
| | | | | | c_{66} |

| | | | | | |
|----------|----------|----------|----------|----------|----------|
| d_{11} | d_{12} | d_{13} | d_{14} | d_{15} | d_{16} |
| d_{21} | d_{22} | d_{23} | d_{24} | d_{25} | d_{26} |
| d_{31} | d_{32} | d_{33} | d_{34} | d_{35} | d_{36} |

```
_prop_elastic_stiffness_cij 'cij'
_prop_piezoelectric_dij 'dij'
_prop_conditions_temperature 257.0(5)
```

```
loop_
_prop_data_label
_prop_data_tensorial_index
_prop_data_value
_prop_measurement_method
cij 11 29.1(1) BS
cij 12 1.8(3) BS
cij 13 1.4(3) BS
cij 22 33.5(2) BS
cij 23 19.8(3) BS
cij 33 26.0(1) BS
cij 44 5.9(1) BS
cij 55 12.9(1) BS
cij 66 16.0(1) BS
dij 15 3100 RUS
dij 24 2435 RUS
dij 32 -302 RUS
dij 33 267 RUS
```

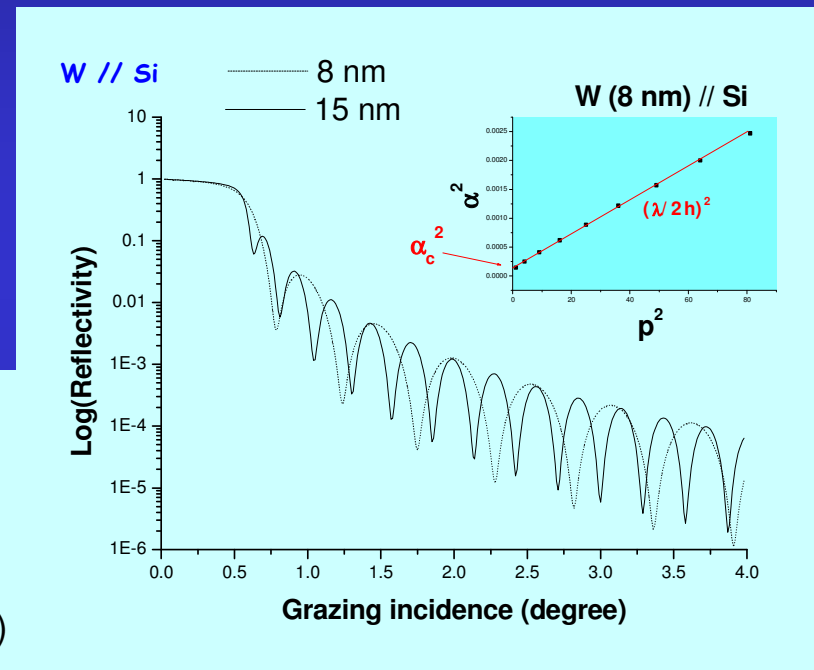

Specular Reflectivity



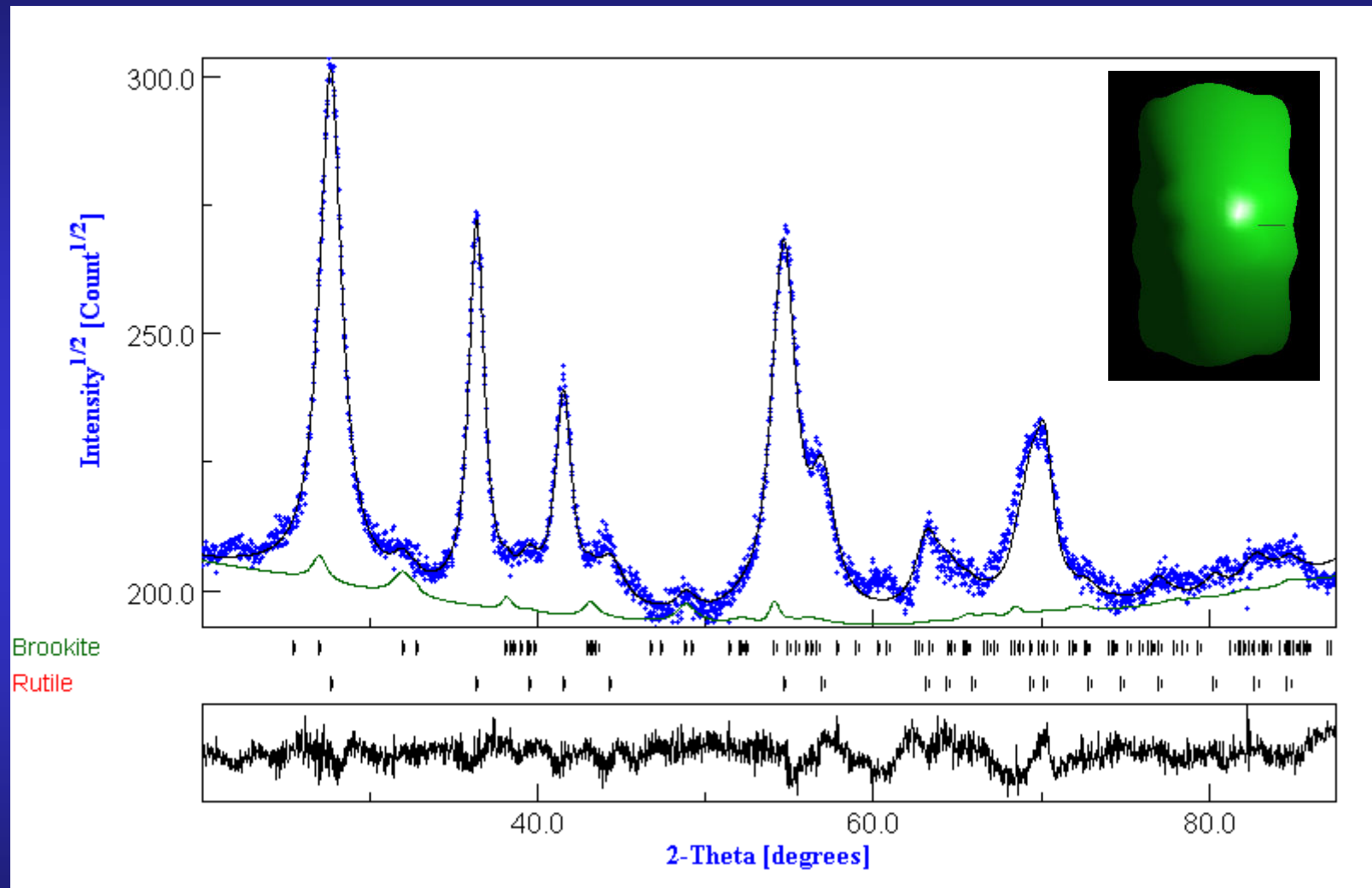
```
#subordinateObject_Layer_x1
```

```
_riet_spec_layer_id 'Layer_x1'  
_riet_par_spec_layer_thickness 142.3256(1.5491493)  
_reflectivity_layer_critical_qc 0.03169255(5.7467838E-5)  
_reflectivity_layer_absorption 5.452058E-8(1.28723885E-8)  
_reflectivity_layer_roughness 0.33851644(0.08996007)
```

```
#end_subordinateObject_Layer_x1
```



Phase Content



| h | k | l | multiplicity | D-spacing | Crystallite | Microstrain |
|---|---|---|--------------|-------------------|------------------|-------------------|
| 1 | 1 | 0 | 4 | 3.239971544546... | 55.1405712350... | 0.007826284017... |
| 1 | 0 | 1 | 8 | 2.479909088830... | 81.9223706294... | 0.003242345868... |
| 2 | 0 | 0 | 4 | 2.29100585 | 31.6754199507... | 0.011068037 |
| 1 | 1 | 1 | 8 | 2.180965464211... | 77.6940457026... | 0.003546382641... |
| 2 | 1 | 0 | 8 | 2.049137926979... | 38.5103939859... | 0.009126937123... |
| 2 | 1 | 1 | 16 | 1.682810130360... | 63.4940322756... | 0.006155376929... |
| 2 | 2 | 0 | 4 | 1.619985772273... | 55.1405712350... | 0.007826284017... |
| 0 | 0 | 2 | 2 | 1.4745978 | 38.2388623632... | 5.354081304805... |
| 3 | 1 | 0 | 8 | 1.448959323754... | 31.9401516263... | 0.010022533775... |
| 2 | 2 | 1 | 8 | 1.419878292695... | 44.9379786288... | 0.006012240827... |
| 3 | 0 | 1 | 8 | 1.356252797441... | 80.5993482184... | 0.008727349807... |

```
_riet_spec_layer_id 'layer1'
```

```
_riet_par_spec_layer_thickness 1.0E8
```

```
loop_
```

```
_pd_phase_atom_%
```

```
0.9201359(0.004872608)
```

```
0.07986411(0.0069217416)
```

```
#end_subordinateObject_layer1
```

Free and Fee Databases and Tools: use CIF intensively !

COD (crystal structures): www.crystallography.net

PCOD (predicted crystal structures): www.crystallography.net/pcod

TCOD (theoretical crystal structures): www.crystallography.net/tcod

MPOD (properties): www.materialproperties.org

PDB (proteins): <http://www.rcsb.org>

NDB (nucleic acids): <http://ndbserver.rutgers.edu/>

AMCSD (minerals): <http://rruff.geo.arizona.edu/AMS/amcsd.php>

IZA (zeolites): <http://www.iza-structure.org/databases>

Raman (minerals): <http://minerals.gps.caltech.edu/files/raman>

Bilbao Server (aperiodic): <http://www.cryst.ehu.es>

Crystal-Eye (merged 2014): <http://wwwmm.ch.cam.ac.uk/crystaleye/>

PubChem

AtomWork

FPSM (Full-Pattern Search-Match): <http://cod.iutcaen.unicaen.fr>

CSD, ICSD, CrystMet, PDF, Pauling, Pearson

Highscore (Panalytical), Eva (Bruker), Search-Match (Crystal Impact),

PDXL (Rigaku), 3DSystems, PolyXtal (Jordan Valley Semiconductors)